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| Notice of References Cited | Application/Control No. 10/735,352 | Applicant(s)/Patent Under Reexamination PURSLEY, MATT D. | |
| | Examiner David T. Beck | Art Unit 1732 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|--------------------------|----------------|
| * | A | US-4,484,586 | 11-1984 | McMickle et al. | 607/122 |
| * | B | US-6,511,462 | 01-2003 | Itou et al. | 604/264 |
| * | C | US-2001/0044633 | 11-2001 | Klint, Henrik Sonderskov | 606/200 |
| * | D | US-5,888,436 | 03-1999 | Keith et al. | 264/103 |
| * | E | US-6,030,371 | 02-2000 | Pursley, Matt D. | 604/527 |
| * | F | US-6,152,912 | 11-2000 | Jansen et al. | 604/526 |
| * | G | US-2001/0041881 | 11-2001 | SARGE et al. | 604/525 |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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